


<b>Search Notes</b>  	<b>Application/Control No.</b>  10598774	<b>Applicant(s)/Patent Under Reexamination</b>  MATSUI ET AL.
	<b>Examiner</b>  Bomkamp, Eric A	<b>Art Unit</b>  2826

SEARCHED			
Class	Subclass	Date	Examiner
349	170, 183	10-15-07	EB
257	E29.323	10-15-07	EB

SEARCH NOTES		
Search Notes	Date	Examiner
Text search in EAST. Search provided by Minh Tran. See atatched	10-15-07	EB

INTERFERENCE SEARCH			
Class	Subclass	Date	Examiner